FAIRCHILD™

Is Now Part of

ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at
www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild_questions@onsemi.com.

FAIRCHILD
SEMICONDUCTOR®

FDB2572

N-Channel PowerTrench® MOSFET
150V, 29A, 54mΩ

Features

- $r_{DS(ON)}$ = 45mΩ (Typ.), V_{GS} = 10V, I_D = 9A
- Q_g(tot) = 26nC (Typ.), V_{GS} = 10V
- Low Miller Charge
- Low Q_{RR} Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)

Formerly developmental type 82860

Applications

- DC/DC converters and Off-Line UPS
- Distributed Power Architectures and VRMs
- Primary Switch for 24V and 48V Systems
- High Voltage Synchronous Rectifier

DRAIN (FLANGE)

GATE

SOURCE

TO-263AB
FDB SERIES

D

G

S
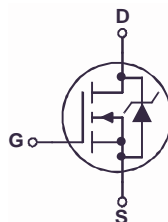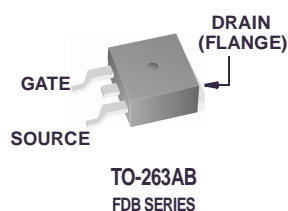
MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DSS}	Drain to Source Voltage	150	V
V_{GS}	Gate to Source Voltage	±20	V
I_D	Drain Current		
	Continuous (T_C = 25°C, V_{GS} = 10V)	29	A
	Continuous (T_C = 100°C, V_{GS} = 10V)	20	A
	Continuous (T_{amb} = 25°C, V_{GS} = 10V, $R_{\theta JA}$ = 43°C/W)	4	A
	Pulsed	Figure 4	A
E_{AS}	Single Pulse Avalanche Energy (Note 1)	36	mJ
P_D	Power dissipation	135	W
	Derate above 25°C	0.9	W/°C
T_J, T_{STG}	Operating and Storage Temperature	-55 to 175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case, TO-263	1.11	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient , TO-263 (Note 2)	62	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient TO-263, 1in^2 copper pad area	43	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB2572	FDB2572	TO-263AB	330mm	24mm	800 units

Electrical Characteristics $T_C = 25°C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min	Typ	Max	Units
Off Characteristics							
B_{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A$, $V_{GS} = 0V$		150	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 120V$		-	-	1	μA
		$V_{GS} = 0V$	$T_C = 150°$	-	-	250	
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm20V$		-	-	±100	nA
On Characteristics							
$V_{GS(TH)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$		2	-	4	V
$r_{DS(ON)}$	Drain to Source On Resistance	$I_D = 9A$, $V_{GS} = 10V$		-	0.045	0.054	Ω
		$I_D = 4A$, $V_{GS} = 6V$,		-	0.050	0.075	
		$I_D = 9A$, $V_{GS} = 10V$, $T_C = 175°C$		-	0.126	0.146	
Dynamic Characteristics							
C_{ISS}	Input Capacitance	$V_{DS} = 25V$, $V_{GS} = 0V$, f = 1MHz		-	1770	-	pF
C_{OSS}	Output Capacitance			-	183	-	pF
C_{RSS}	Reverse Transfer Capacitance			-	40	-	pF
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0V$ to 10V	$V_{DD} = 75V$ $I_D = 9A$ $I_g = 1.0mA$	-	26	34	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0V$ to 2V		-	3.3	4.3	nC
Q_{gs}	Gate to Source Gate Charge			-	8	-	nC
Q_{gs2}	Gate Charge Threshold to Plateau			-	5	-	nC
Q_{gd}	Gate to Drain "Miller" Charge			-	6	-	nC
Resistive Switching Characteristics $(V_{GS} = 10V)$							
t_{ON}	Turn-On Time	$V_{DD} = 75V$, $I_D = 9A$ $V_{GS} = 10V$, $R_{GS} = 11.0\Omega$		-	-	36	ns
$t_{d(ON)}$	Turn-On Delay Time			-	11	-	ns
t_r	Rise Time			-	14	-	ns
$t_{d(OFF)}$	Turn-Off Delay Time			-	31	-	ns
t_f	Fall Time			-	14	-	ns
t_{OFF}	Turn-Off Time			-	-	66	ns
Drain-Source Diode Characteristics							
V_{SD}	Source to Drain Diode Voltage	$I_{SD} = 9A$		-	-	1.25	V
		$I_{SD} = 4A$		-	-	1.0	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 9A$, $dI_{SD}/dt = 100A/\mu s$		-	-	74	ns
Q_{RR}	Reverse Recovered Charge	$I_{SD} = 9A$, $dI_{SD}/dt = 100A/\mu s$		-	-	169	nC

Notes:
1: Starting $T_J = 25°C$, L = 0.2mH, $I_{AS} = 19A$.
2: Pulse Width = 100s

Typical Characteristics T_C = 25°C unless otherwise noted
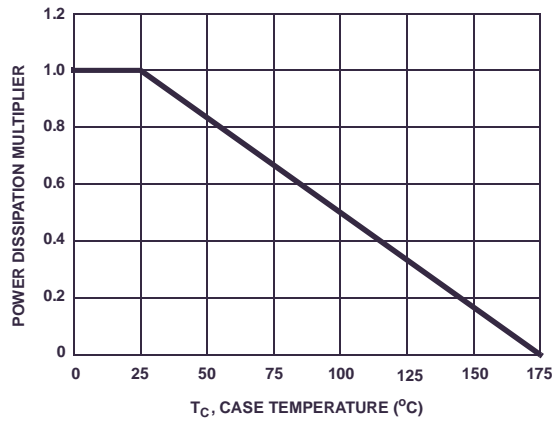
Figure 1. Normalized Power Dissipation vs Ambient Temperature
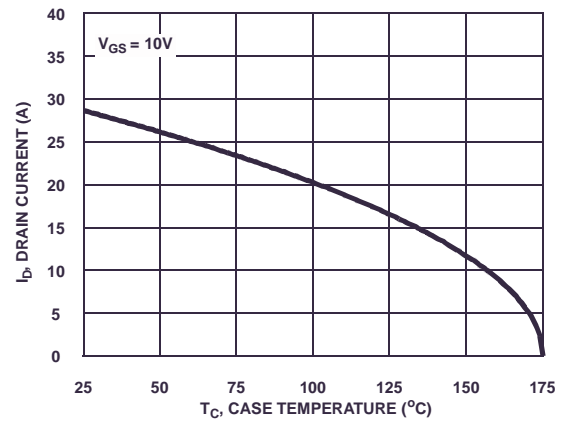
Figure 2. Maximum Continuous Drain Current vs Case Temperature

NOTES:
DUTY FACTOR: $D = t_1/t_2$
PEAK $T_J = P_{DM}$ x $Z_{\theta JC}$ x $R_{\theta JC} + T_C$
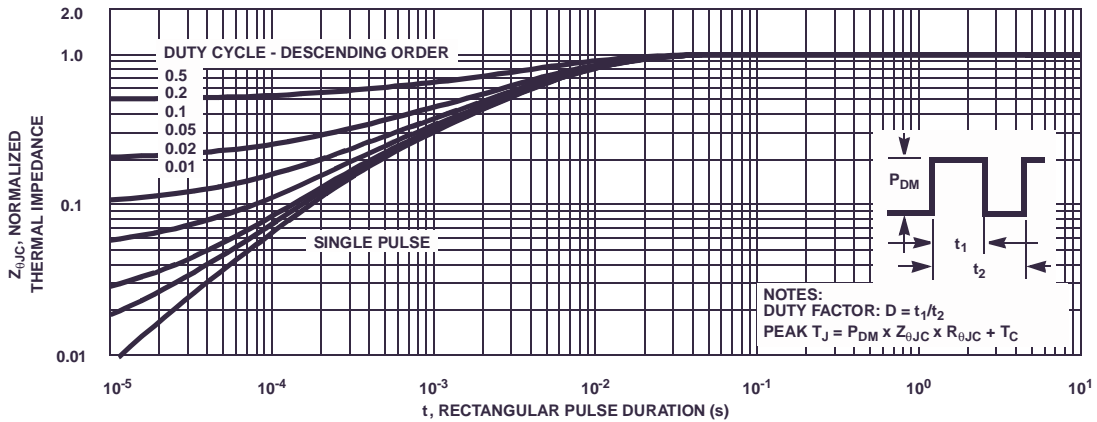
Figure 3. Normalized Maximum Transient Thermal Impedance

T_C = 25°C
FOR TEMPERATURES ABOVE 25°C DERATE PEAK CURRENT AS FOLLOWS:

$$I = I_{25} \sqrt{\frac{175 - T_C}{150}}$$

Figure 4. Peak Current Capability

Typical Characteristics T_C = 25°C unless otherwise noted
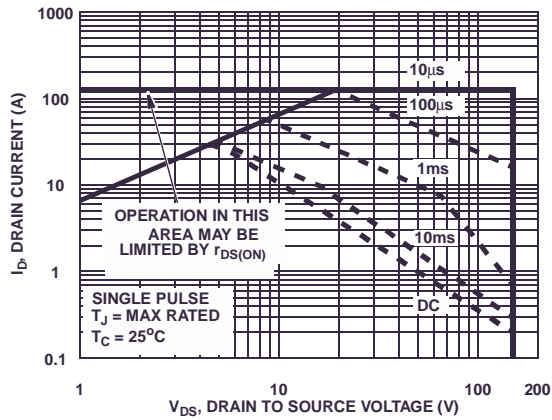
Figure 5. Forward Bias Safe Operating Area

OPERATION IN THIS AREA MAY BE LIMITED BY $r_{DS(ON)}$

SINGLE PULSE
T_J = MAX RATED
T_C = 25°C

I_D, DRAIN CURRENT (A)

V_{DS}, DRAIN TO SOURCE VOTLAGE (V)

10µs
100µs
1ms
10ms
DC
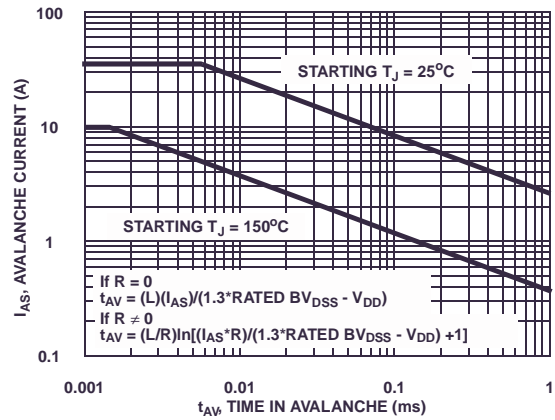
NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability

STARTING T_J = 25°C

STARTING T_J = 150°C

If R = 0
t_{AV} = (L)(I_{AS})/(1.3*RATED BV_{DSS} - V_{DD})
If R ≠ 0
t_{AV} = (L/R)ln[(I_{AS}*R)/(1.3*RATED BV_{DSS} - V_{DD}) +1]
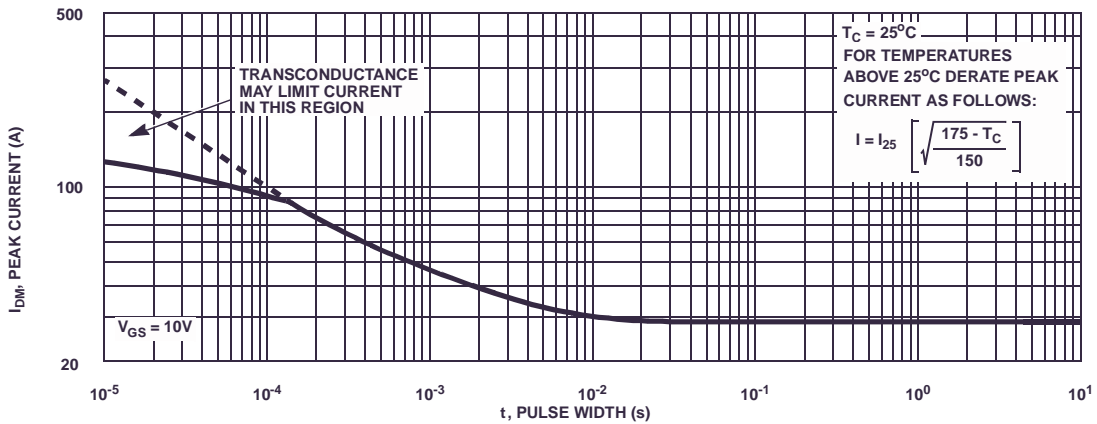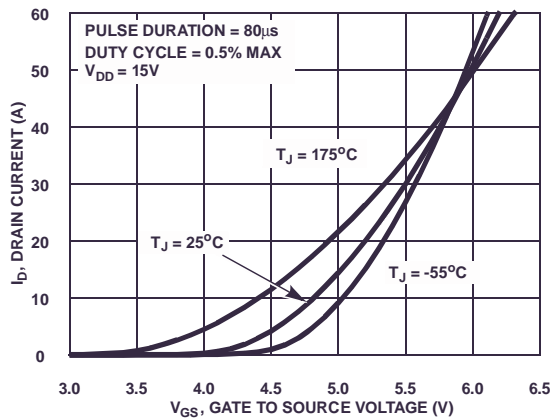
I_{AS}, AVALANCHE CURRENT (A)

t_{AV}, TIME IN AVALANCHE (ms)

PULSE DURATION = 80µs
DUTY CYCLE = 0.5% MAX
V_{DD} = 15V

T_J = 175°C
T_J = 25°C
T_J = -55°C

I_D, DRAIN CURRENT (A)

V_{GS}, GATE TO SOURCE VOLTAGE (V)

Figure 7. Transfer Characteristics

T_C = 25°C
V_{GS} = 10V
V_{GS} = 7V
V_{GS} = 6V
V_{GS} = 5V

PULSE DURATION = 80µs
DUTY CYCLE = 0.5% MAX

I_D, DRAIN CURRENT (A)

V_{DS}, DRAIN TO SOURCE VOLTAGE (V)
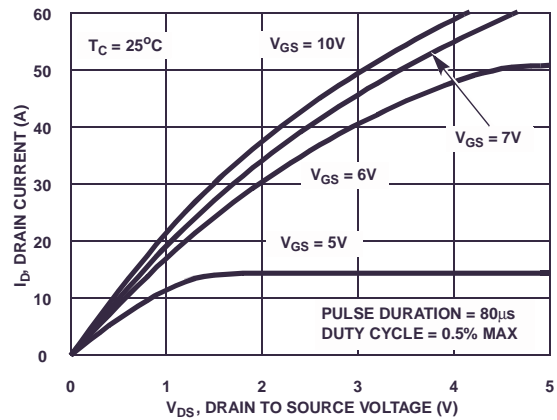
Figure 8. Saturation Characteristics

PULSE DURATION = 80µs
DUTY CYCLE = 0.5% MAX

V_{GS} = 6V
V_{GS} = 10V

DRAIN TO SOURCE ON RESISTANCE (m Ω)
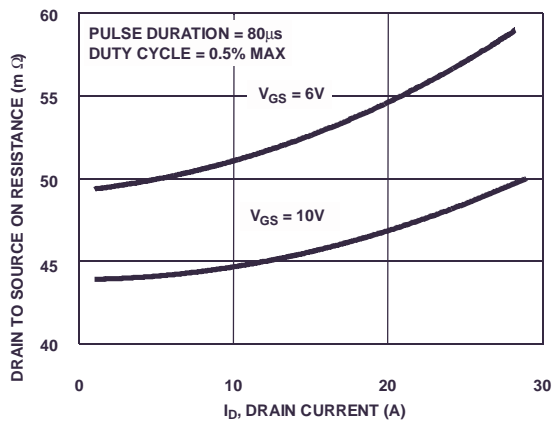
I_D, DRAIN CURRENT (A)

Figure 9. Drain to Source On Resistance vs Drain Current

PULSE DURATION = 80µs
DUTY CYCLE = 0.5% MAX

V_{GS} = 10V, I_D =9A

NORMALIZED DRAIN TO SOURCE ON RESISTANCE

T_J, JUNCTION TEMPERATURE (°C)

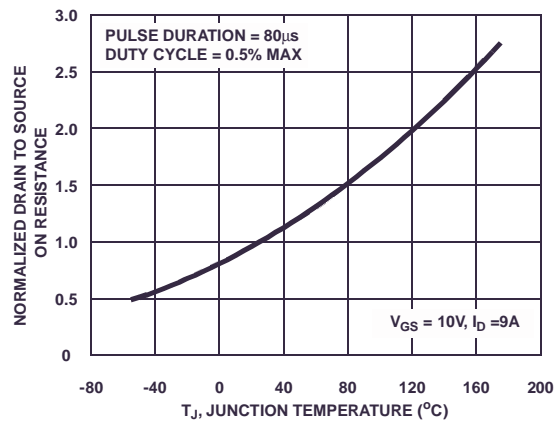**Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature**

Typical Characteristics T_C = 25°C unless otherwise noted
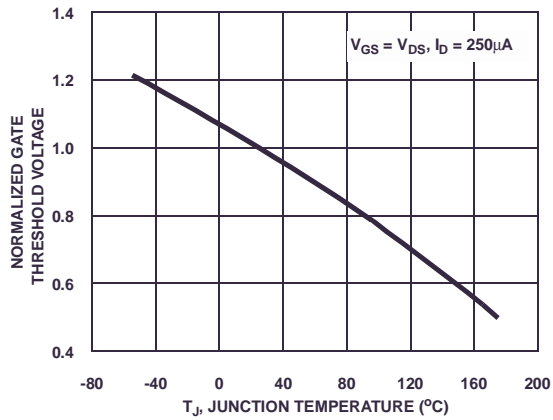
Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature
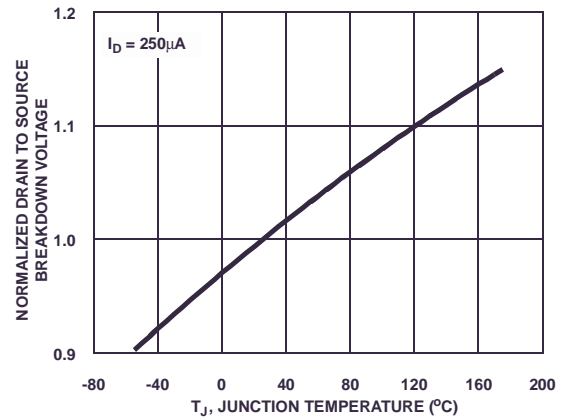
Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature
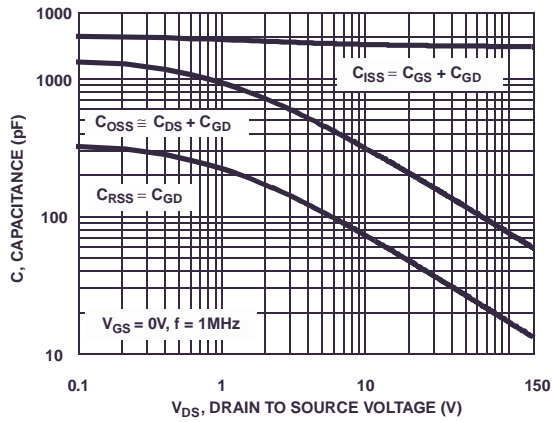
Figure 13. Capacitance vs Drain to Source Voltage

Figure 14. Gate Charge Waveforms for Constant Gate Currents

Test Circuits and Waveforms

Figure 15. Unclamped Energy Test Circuit

Figure 16. Unclamped Energy Waveforms

Figure 17. Gate Charge Test Circuit

Figure 18. Gate Charge Waveforms

Figure 19. Switching Time Test Circuit

Figure 20. Switching Time Waveforms

Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM}, and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM},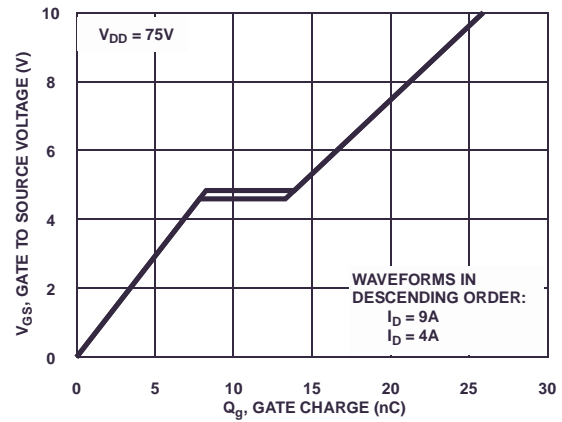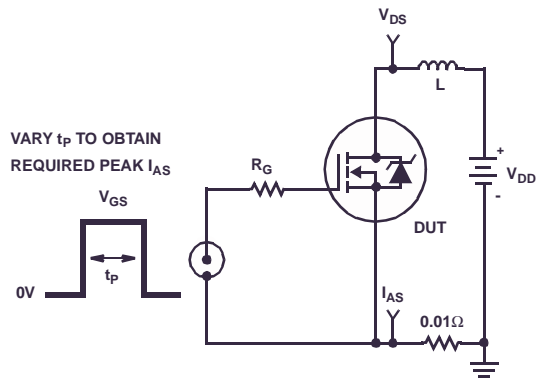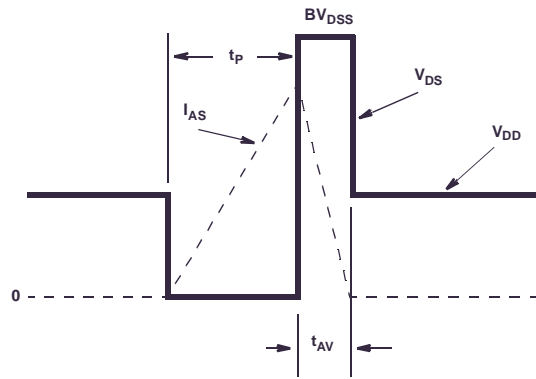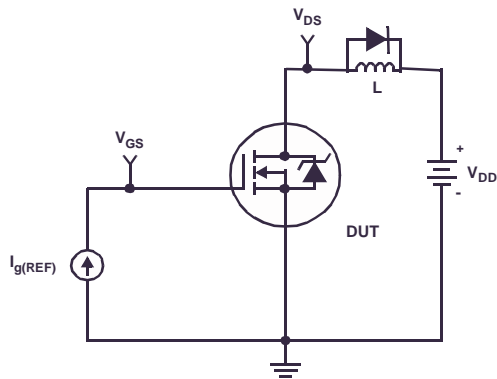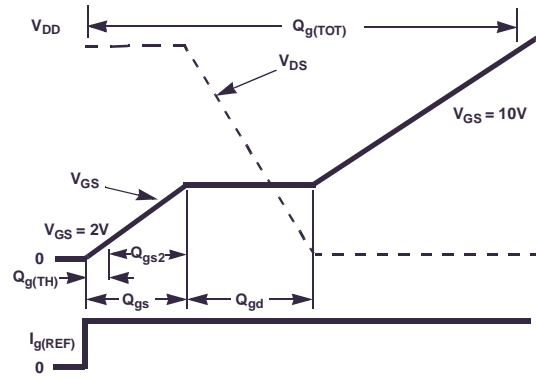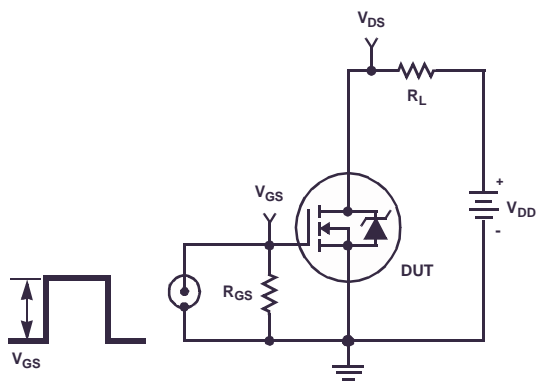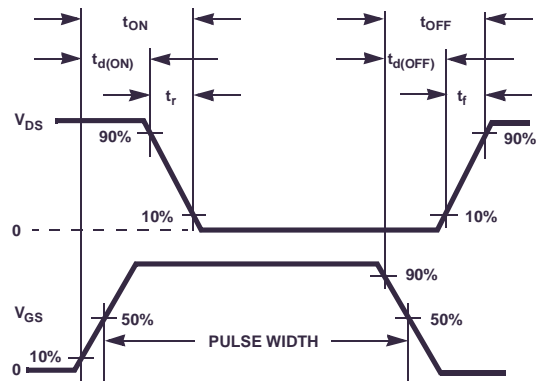 in an application. Therefore the application's ambient temperature, T_A (^{o}C), and thermal resistance $R_{\theta JA}$ (^{o}C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$ (EQ. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.

2. The number of copper layers and the thickness of the board.

3. The use of external heat sinks.

4. The use of thermal vias.

5. Air flow and board orientation.

6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeter square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$ (EQ. 2)

Area in Inches Squared

$$R_{\theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$ (EQ. 3)
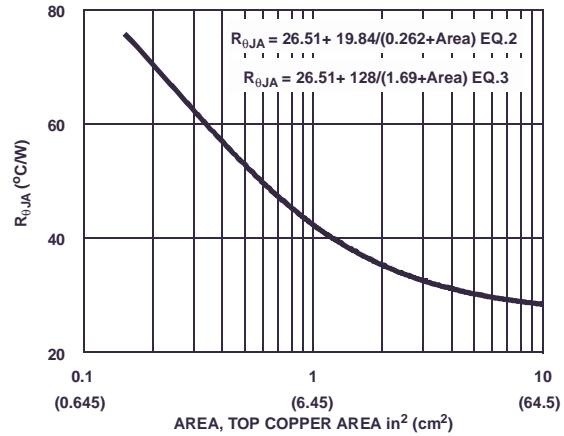
Area in Centimeters Squared

Figure 21. Thermal Resistance vs Mounting Pad Area

PSPICE Electrical Model

.SUBCKT FDB2572 2 1 3 ;   rev April 2002
CA 12 8 5.5e-10
Cb 15 14 7.4e-10
Cin 6 8 1.7e-9

Dbody 7 5 DbodyMOD
Dbreak 5 11 DbreakMOD
Dplcap 10 5 DplcapMOD

Ebreak 11 7 17 18 160
Eds 14 8 5 8 1
Egs 13 8 6 8 1
Esg 6 10 6 8 1
Evthres 6 21 19 8 1
Evtemp 20 6 18 22 1

It 8 17 1

Lgate 1 9 9.56e-9
Ldrain 2 5 1.0e-9
Lsource 3 7 7.71e-9

RLgate 1 9 95.6
RLdrain 2 5 10
RLsource 3 7 77.1

Mmed 16 6 8 8 MmedMOD
Mstro 16 6 8 8 MstroMOD
Mweak 16 21 8 8 MweakMOD

Rbreak 17 18 RbreakMOD 1
Rdrain 50 16 RdrainMOD 35e-3
Rgate 9 20 1.6
RSLC1 5 51 RSLCMOD 1.0e-6
RSLC2 5 50 1.0e3
Rsource 8 7 RsourceMOD 3.0e-3
Rvthres 22 8 RvthresMOD 1
Rvtemp 18 19 RvtempMOD 1
S1a 6 12 13 8 S1AMOD
S1b 13 12 13 8 S1BMOD
S2a 6 15 14 13 S2AMOD
S2b 13 15 14 13 S2BMOD

Vbat 22 19 DC 1

ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*52),3))}

.MODEL DbodyMOD D (IS=6.0E-11 N=1.14 RS=3.9e-3 TRS1=3.5e-3 TRS2=3.0e-6
+ CJO=1.1e-9 M=0.63 TT=6.2e-8 XTI=4.5)
.MODEL DbreakMOD D (RS=10 TRS1=5.0e-3 TRS2=-5.0e-6)
.MODEL DplcapMOD D (CJO=3.5e-10 IS=1.0e-30 N=10 M=0.65)

.MODEL MmedMOD NMOS (VTO=3.55 KP=3 IS=1e-40 N=10 TOX=1 L=1u W=1u RG=1.6)
.MODEL MstroMOD NMOS (VTO=4.0 KP=25 IS=1e-30 N=10 TOX=1 L=1u W=1u)
.MODEL MweakMOD NMOS (VTO=2.95 KP=0.05 IS=1e-30 N=10 TOX=1 L=1u W=1u RG=16 RS=0.1)

.MODEL RbreakMOD RES (TC1=1.15e-3 TC2=-9.5e-7)
.MODEL RdrainMOD RES (TC1=9.0e-3 TC2=2.5e-5)
.MODEL RSLCMOD RES (TC1=3.0e-3 TC2=2.5e-6)
.MODEL RsourceMOD RES (TC1=4.0e-3 TC2=1.0e-6)
.MODEL RvthresMOD RES (TC1=-4.1e-3 TC2=-1.0e-5)
.MODEL RvtempMOD RES (TC1=-4.0e-3 TC2=1.0e-6)

.MODEL S1AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-5.0 VOFF=-3.5)
.MODEL S1BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-3.5 VOFF=-5.0)
.MODEL S2AMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=-0.5 VOFF=0.3)
.MODEL S2BMOD VSWITCH (RON=1e-5 ROFF=0.1 VON=0.3 VOFF=-0.5)
.ENDS
Note: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

SABER Electrical Model

```
REV April 2002
ttemplate FDB2572 n2,n1,n3
electrical n2,n1,n3
{
var i iscl
dp..model dbodymod =  (isl=6.0e-11,nl=1.14,rs=3.9e-3,trs1=3.5e-3,trs2=3.0e-6,cjo=1.1e-9,m=0.63,tt=6.2e-8,xti=4.5)
dp..model dbreakmod = (rs=10,trs1=5.0e-3,trs2=-5.0e-6)
dp..model dplcapmod =  (cjo=3.5e-10,isl=10.0e-30,nl=10,m=0.65)
m..model mmedmod = (type=_n,vto=3.55,kp=3,is=1e-40, tox=1)
m..model mstrongmod = (type=_n,vto=4.0,kp=25,is=1e-30, tox=1)
m..model mweakmod = (type=_n,vto=2.95,kp=0.05,is=1e-30, tox=1,rs=0.1)
sw_vcsp..model s1amod =  (ron=1e-5,roff=0.1,von=-5.0,voff=-3.5)
sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-3.5,voff=-5.0)
sw_vcsp..model s2amod =  (ron=1e-5,roff=0.1,von=-0.5,voff=0.3)
sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=0.3,voff=-0.5)
c.ca n12 n8 = 5.5e-10
c.cb n15 n14 = 7.4e-10
c.cin n6 n8 = 1.7e-9

dp.dbody n7 n5 = model=dbodymod
dp.dbreak n5 n11 = model=dbreakmod
dp.dplcap n10 n5 = model=dplcapmod

spe.ebreak n11 n7 n17 n18 = 160
spe.eds n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evthres n6 n21 n19 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1

i.it n8 n17 = 1

l.lgate n1 n9 = 9.56e-9
l.ldrain n2 n5 = 1.0e-9
l.lsource n3 n7 = 7.71e-9

res.rlgate n1 n9 = 95.6
res.rldrain n2 n5 = 10
res.rlsource n3 n7 = 77.1

m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u

res.rbreak n17 n18  = 1, tc1=1.15e-3,tc2=-9.5e-7
res.rdrain n50 n16  = 35e-3, tc1=9.0e-3,tc2=2.5e-5
res.rgate n9 n20 = 1.6
res.rslc1 n5 n51  = 1.0e-6, tc1=3.0e-3,tc2=2.5e-6
res.rslc2 n5 n50 = 1.0e3
res.rsource n8 n7  = 3.0e-3, tc1=4.0e-3,tc2=1.0e-6
res.rvthres n22 n8  = 1, tc1=-4.1e-3,tc2=-1.0e-5
res.rvtemp n18 n19  = 1, tc1=-4.0e-3,tc2=1.0e-6
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod

v.vbat n22 n19 = dc=1
equations {
i (n51->n50) +=iscl
iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/52))** 3))}
}
```

SPICE Thermal Model

REV 26 April 2002

FDB2572

CTHERM1 TH 6 3.8e-3
CTHERM2 6 5 4.0e-3
CTHERM3 5 4 4.2e-3
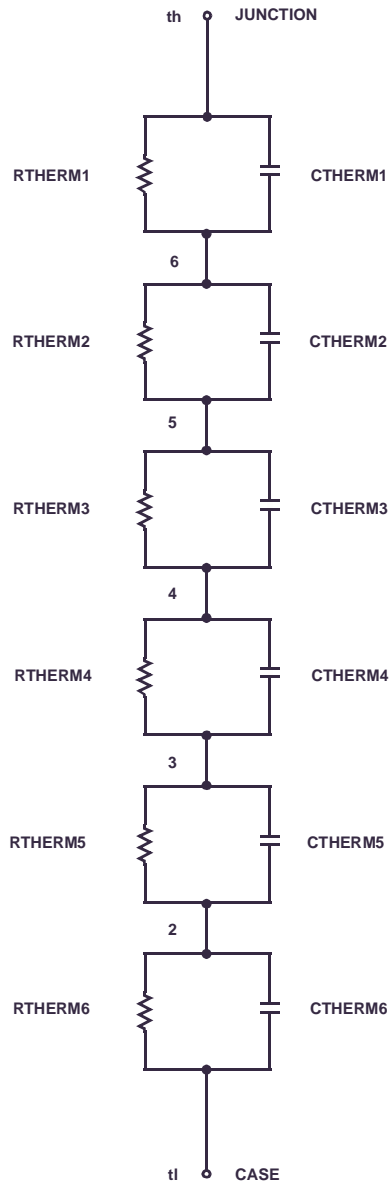CTHERM4 4 3 4.3e-3
CTHERM5 3 2 8.5e-3
CTHERM6 2 TL 3.0e-2

RTHERM1 TH 6 5.5e-4
RTHERM2 6 5 5.0e-3
RTHERM3 5 4 4.5e-2
RTHERM4 4 3 10.5e-2
RTHERM5 3 2 3.7e-1
RTHERM6 2 TL 3.8e-1

SABER Thermal Model

SABER thermal model FDB2572
template thermal_model th tl
thermal_c th, tl
{
ctherm.ctherm1 th 6 =3.8e-3
ctherm.ctherm2 6 5 =4.0e-3
ctherm.ctherm3 5 4 =4.2e-3
ctherm.ctherm4 4 3 =4.3e-3
ctherm.ctherm5 3 2 =8.5e-3
ctherm.ctherm6 2 tl =3.0e-2

rtherm.rtherm1 th 6 =5.5e-4
rtherm.rtherm2 6 5 =5.0e-3
rtherm.rtherm3 5 4 =4.5e-2
rtherm.rtherm4 4 3 =10.5e-2
rtherm.rtherm5 3 2 =3.7e-1
rtherm.rtherm6 2 tl =3.8e-1
}

th   JUNCTION

RTHERM1   CTHERM1

6

RTHERM2   CTHERM2

5

RTHERM3   CTHERM3

4

RTHERM4   CTHERM4

3

RTHERM5   CTHERM5

2

RTHERM6   CTHERM6

tl   CASE

TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

2Cool™	F-PFS™	PowerTrench®	The Power Franchise®
AccuPower™	FRFET®	PowerXS™	
AX-CAP™*	Global Power Resource℠	Programmable Active Droop™	the **p**⊙**wer**® franchise
BitSiC®	Green Bridge™	QFET®	
Build it Now™	Green FPS™	QS™	TinyBoost™
CorePLUS™	Green FPS™ e-Series™	Quiet Series™	TinyBuck™
CorePOWER™	G*max*™	RapidConfigure™	TinyCalc™
CROSSVOLT™	GTO™		TinyLogic®
CTL™	IntelliMAX™	⊙ ™	TINYOPTO™
Current Transfer Logic™	ISOPLANAR™	Saving our world, 1mW/W/kW at a time™	TinyPower™
DEUXPEED®	Marking Small Speakers Sound Louder	SignalWise™	TinyPWM™
Dual Cool™	and Better™	SmartMax™	TinyWire™
EcoSPARK®	MegaBuck™	SMART START™	TranSiC®
EffcentMax™	MICROCOUPLER™	Solutions for Your Success™	TriFault Detect™
ESBC™	MicroFET™	SPM®	TRUECURRENT®*
	MicroPak™	STEALTH™	µSerDes™
F®	MicroPak2™	SuperFET®	
	MillerDrive™	SuperSOT™-3	µSerDes™
Fairchild®	MotionMax™	SuperSOT™-6	
Fairchild Semiconductor®	Motion-SPM™	SuperSOT™-8	UHC®
FACT Quiet Series™	mWSaver™	SupreMOS®	Ultra FRFET™
FACT®	OptoHiT™	SyncFET™	UniFET™
FAST®	OPTOLOGIC®	Sync-Lock™	VCX™
FastvCore™	OPTOPLANAR®		VisualMax™
FETBench™		**SYSTEM GENERAL**®*	VoltagePlus™
FlashWriter® *	⊙ ®		XS™
FPS™			

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.

2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS
Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. I61

PUBLICATION ORDERING INFORMATION

© Semiconductor Components Industries, LLC